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With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

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Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832

Email & Skype: info@chipsmall.com Web: www.chipsmall.com

Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China







2SD2374A

Silicon NPN triple diffusion planar type

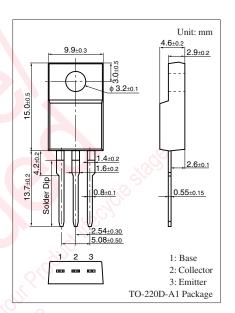
For power amplification Complementary to 2SB1548A

■ Features

- High forward current transfer ratio h_{FE} which has satisfactory linearity
- Low collector-emitter saturation voltage V_{CE(sat)}
- Full-pack package which can be installed to the heat sink with one screw

■ Absolute Maximum Ratings $T_a = 25$ °C

Parameter	Symbol	Rating	Unit	
Collector-base voltage (Emitter open)	V_{CBO}	80	V	
Collector-emitter voltage (Base open)	V _{CEO}	80	V	
Emitter-base voltage (Collector open)	$V_{\rm EBO}$	6	V	
Collector current	I_{C}	3	A	
Peak collector current	I _{CP}	5	A	
Collector power $T_C = 25^{\circ}C$	P _C	25	W	
dissipation		2.0	4011	
Junction temperature	T_{j}	150	°C €	
Storage temperature	T_{stg}	-55 to +150	°C	



■ Electrical Characteristics $T_a = 25$ °C ± 3 °C

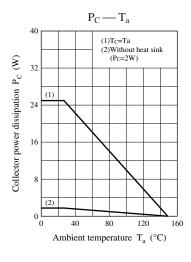
Parameter	Symbol	Conditions	Min	Тур	Max	Unit
Collector-emitter voltage (Base open)	V _{CEO}	$I_C = 30 \text{ mA}, I_B = 0$	80			V
Base-emitter voltage	V_{BE}	$V_{CE} = 4 \text{ V}, I_{C} = 3 \text{ A}$	1.1		1.8	V
Collector-emitter cutoff current (E-B short)	I _{CES}	$V_{CE} = 80 \text{ V}, V_{BE} = 0$			200	μΑ
Collector-emitter cutoff current (Base open)	I_{CEO}	$V_{CE} = 60 \text{ V}, I_{B} = 0$			300	μΑ
Emitter-base cutoff current (Collector open)	I_{EBO}	$V_{EB} = 6 \text{ V}, I_{C} = 0$			1	mA
Forward current transfer ratio	h _{FE1} *	$V_{CE} = 4 \text{ V}, I_{C} = 1 \text{ A}$	70		250	_
	h _{FE2}	$V_{CE} = 4 \text{ V}, I_{C} = 3 \text{ A}$	10			
Collector-emitter saturation voltage	V _{CE(sat)}	$I_C = 3 \text{ A}, I_B = 0.375 \text{ A}$			1.2	V
Transition frequency	f_T	$V_{CE} = 10 \text{ V}, I_{C} = 0.5 \text{ A}, f = 10 \text{ MHz}$		30		MHz
Turn-on time	t _{on}	$I_C = 1 \text{ A}, I_{B1} = 0.1 \text{ A}, I_{B2} = -0.1 \text{ A}$		0.5		μs
Storage time	t _{stg}	$V_{CC} = 50 \text{ V}$		2.5		μs
Fall time	$t_{\rm f}$			0.4		μs

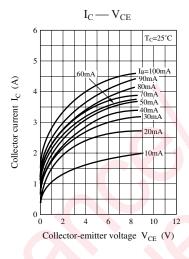
Note) 1. Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7030 measuring methods for transistors.

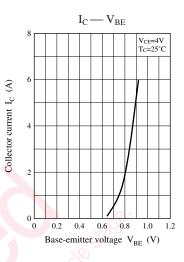
2. *: Rank classification

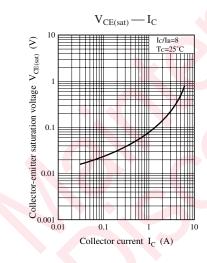
Rank	Q	Р
h_{FE1}	70 to 150	120 to 250

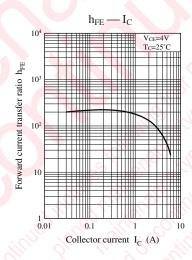
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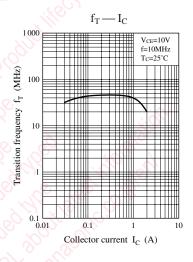


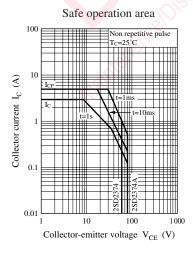


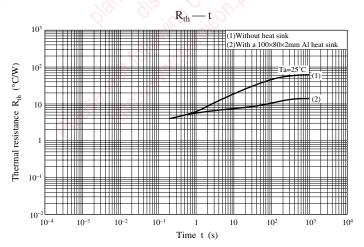












2 SJD00261BED

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